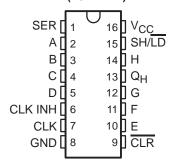
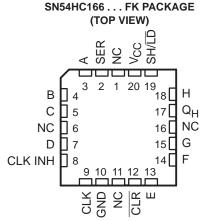
- Wide Operating Voltage Range of 2 V to 6 V
- Outputs Can Drive Up To 10 LSTTL Loads
- Low Power Consumption, 80-μA Max I_{CC}
- Typical t_{pd} = 13 ns
- ±4-mA Output Drive at 5 V

SN54HC166 . . . J OR W PACKAGE SN74HC166 . . . D, DB, N, NS, OR PW PACKAGE (TOP VIEW)



- Low Input Current of 1 μA Max
- Synchronous Load
- Direct Overriding Clear
- Parallel-to-Serial Conversion



NC - No internal connection

description/ordering information

ORDERING INFORMATION

TA	PACKA	PACKAGET P		TOP-SIDE MARKING
	PDIP – N	Tube of 25	SN74HC166N	SN74HC166N
		Tube of 40	SN74HC166D	
	SOIC - D	Reel of 2500	SN74HC166DR	HC166
		Reel of 250	SN74HC166DT	
-40°C to 85°C	SOP - NS	OP – NS Reel of 2000 SN7		HC166
	SSOP – DB	Reel of 2000	SN74HC166DBR	HC166
		Tube of 90	SN74HC166PW	
	TSSOP - PW	Reel of 2000	SN74HC166PWR	HC166
		Reel of 250	SN74HC166PWT	
	CDIP – J	Tube of 25	SNJ54HC166J	SNJ54HC166J
-55°C to 125°C	CFP – W	Tube of 150	SNJ54HC166W	SNJ54HC166W
	LCCC – FK	Tube of 55	SNJ54HC166FK	SNJ54HC166FK

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



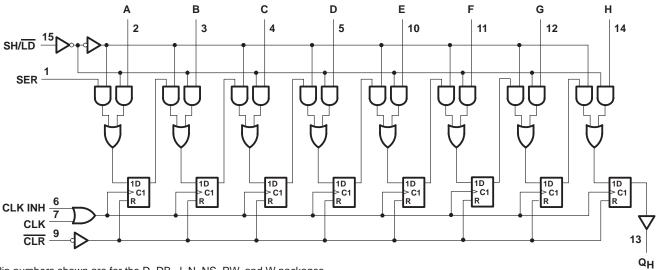
description/ordering information (continued)

These parallel-in or serial-in, serial-out registers feature gated clock (CLK, CLK INH) inputs and an overriding clear (CLR) input. The parallel-in or serial-in modes are established by the shift/load (SH/LD) input. When high, SH/LD enables the serial (SER) data input and couples the eight flip-flops for serial shifting with each clock (CLK) pulse. When low, the parallel (broadside) data inputs are enabled, and synchronous loading occurs on the next clock pulse. During parallel loading, serial data flow is inhibited. Clocking is accomplished on the low-to-high-level edge of CLK through a 2-input positive-NOR gate, permitting one input to be used as a clock-enable or clock-inhibit function. Holding either CLK or CLK INH high inhibits clocking; holding either low enables the other clock input. This allows the system clock to be free running, and the register can be stopped on command with the other clock input. CLK INH should be changed to the high level only when CLK is high. CLR overrides all other inputs, including CLK, and resets all flip-flops to zero.

FUNCTION TABLE

INDUTO							UTPUT	S
		INPUTS					RNAL	
CLR	SH/LD	CLK INH	CLK	SER	PARALLEL AH	Q _A	QB	Q _H
L	Х	Χ	Χ	Χ	X	L	L	L
Н	Χ	L	L	Χ	X	Q _{A0}	Q_{B0}	Q _{H0}
Н	L	L	\uparrow	Χ	ah	а	b	h
Н	Н	L	\uparrow	Н	X	Н	Q_{An}	QGn
Н	Н	L	\uparrow	L	Χ	L	Q_{An}	Q _{Gn}
Н	X	Н	\uparrow	X	X	Q _{A0}	Q_{B0}	Q _{H0}

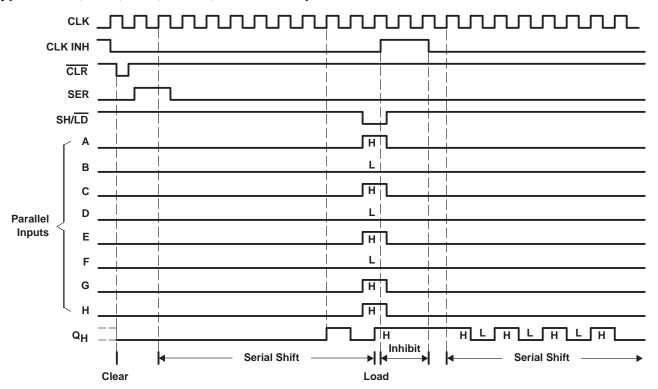
logic diagram (positive logic)



Pin numbers shown are for the D, DB, J, N, NS, PW, and W packages.



typical clear, shift, load, inhibit, and shift sequence



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Les Calana a mand L. A. Canalla M. A. Canalla M. A. Canalla M. A. Canalla M.	+20 m∆
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	. ±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	. ±25 mA
Continuous current through V _{CC} or GND	. ±50 mA
Package thermal impedance, θ _{JA} (see Note 2): D package	. 73°C/W
DB package	. 82°C/W
N package	. 67°C/W
NS package	. 64°C/W
PW package	108°C/W
Storage temperature range, T _{stg} –65°C	to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



SN54HC166, SN74HC166 8-BIT PARALLEL-LOAD SHIFT REGISTERS

SCLS117D - DECEMBER 1982 - REVISED SEPTEMBER 2003

recommended operating conditions (see Note 3)

			SN	154HC16	66	SN74HC166			
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		2	5	6	2	5	6	V
		V _{CC} = 2 V	1.5			1.5			
ViH	High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			V
		V _{CC} = 6 V	4.2			4.2			
	Low-level input voltage	V _{CC} = 2 V			0.5			0.5	V
٧ _{IL}		V _{CC} = 4.5 V			1.35			1.35	
		VCC = 6 V			1.8			1.8	
VI	Input voltage		0		VCC	0		VCC	V
٧o	Output voltage		0		VCC	0		VCC	V
		V _{CC} = 2 V			1000			1000	
Δt/Δv†	Input transition rise/fall time	V _{CC} = 4.5 V			500			500	ns
		V _{CC} = 6 V			400			400	
TA	Operating free-air temperature		-55		125	-40		85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	PARAMETER TEST CONDITIONS		, , , , , , , , , , , , , , , , , , ,	Т	A = 25°C	;	SN54H	C166	SN74H	C166	
PARAMETER	TEST CC	ONDITIONS	vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		1.9		
		I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		
Voн	VI = VIH or VIL		6 V	5.9	5.999		5.9		5.9		V
		$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
		$I_{OH} = -5.2 \text{ mA}$	6 V	5.48	5.8		5.2		5.34		
	VI = VIH or VIL	I _{OL} = 20 μA	2 V		0.002	0.1		0.1		0.1	
			4.5 V		0.001	0.1		0.1		0.1	
VOL			6 V		0.001	0.1		0.1		0.1	V
		I _{OL} = 4 mA	4.5 V		0.17	0.26		0.4		0.33	
		$I_{OL} = 5.2 \text{ mA}$	6 V		0.15	0.26		0.4		0.33	
lį	$V_I = V_{CC}$ or 0		6 V		±0.1	±100		±1000		±1000	nA
Icc	$V_I = V_{CC}$ or 0,	IO = 0	6 V			8		160		80	μΑ
Ci			2 V to 6 V		3	10		10		10	pF

[†] If this device is used in the threshold region (from $V_{IL}max = 0.5 \text{ V}$ to $V_{IH}min = 1.5 \text{ V}$), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at $t_t = 1000$ ns and $V_{CC} = 2 \text{ V}$ does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.

SN54HC166, SN74HC166 8-BIT PARALLEL-LOAD SHIFT REGISTERS

SCLS117D - DECEMBER 1982 - REVISED SEPTEMBER 2003

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

				T _A =			IC166	SN74HC166		
			VCC	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		6		4.2		5	
fclock	Clock frequency		4.5 V		31		21		25	MHz
			6 V		36		25		29	
			2 V	100		150		125		
		CLR low	4.5 V	20		30		25		
	Dulas dimetias		6 V	17		26		21		
t _W	Pulse duration		2 V	80		120		100		ns
		CLK high or low	4.5 V	16		24		20		
			6 V	14		20		17		
			2 V	145		220		180		
		SH/LD high before CLK↑	4.5 V	29		44		36		
			6 V	25		38		31		
			2 V	80		120		100		
		SER before CLK↑	4.5 V	16		24		20		ns
			6 V	14		20		17		
	t _{Su} Setup time		2 V	100		150		125		
t _{su}		CLK INH low before CLK↑	4.5 V	20		30		25		
			6 V	17		26		21		
			2 V	80		120		100		
		Data before CLK↑	4.5 V	16		24		20		
			6 V	14		20		17		
			2 V	40		60		50		
		CLR inactive before CLK↑	4.5 V	8		12		10		
			6 V	7		10		9		
			2 V	0		0		0		
		SH/LD high after CLK↑	4.5 V	0		0		0		
			6 V	0		0		0		
			2 V	5		5		5		
		SER after CLK↑	4.5 V	5		5		5		
t _h Hold time		6 V	5		5		5			
		2 V	0		0		0		ns	
		CLK INH high after CLK↑	4.5 V	0		0		0		
			6 V	0		0		0		
			2 V	5		5		5		
		Data after CLK↑	4.5 V	5		5		5		
			6 V	5		5		5		



SN54HC166, SN74HC166 8-BIT PARALLEL-LOAD SHIFT REGISTERS

SCLS117D - DECEMBER 1982 - REVISED SEPTEMBER 2003

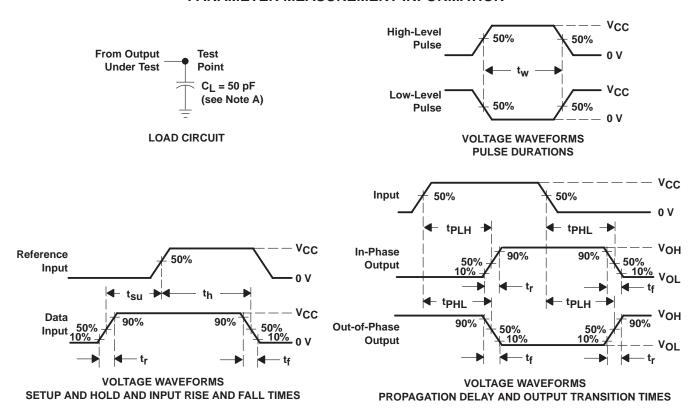
switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

	FROM	то	,,	T,	ղ = 25°C	;	SN54H	C166	SN74H	IC166	
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	6	11		4.2		5		
fmax			4.5 V	31	36		21		25		MHz
			6 V	36	45		25		29		
	CLR	QH	2 V		62	120		180		150	
t _{PHL}			4.5 V		18	24		36		30	ns
			6 V		13	20		31		26	
			2 V		75	150		225		190	
^t pd	CLK	QH	4.5 V		15	30		45		38	ns
'			6 V		13	26		38		32	
		Any	2 V		38	75		110		95	
t _t			4.5 V		8	15		22		19	ns
			6 V		6	13		19		16	

operating characteristics, $T_A = 25^{\circ}C$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	No load	50	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and test-fixture capacitance.

- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_f = 6 \ ns$, $t_f = 6 \ ns$.
- C. For clock inputs, f_{max} is measured when the input duty cycle is 50%.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

FK (S-CQCC-N**)

28 TERMINAL SHOWN

LEADLESS CERAMIC CHIP CARRIER



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. The terminals are gold plated.
- E. Falls within JEDEC MS-004



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

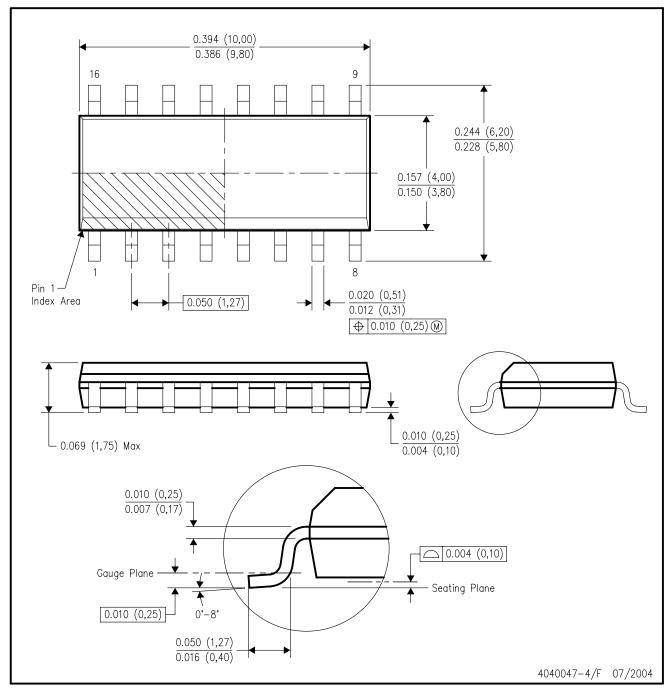


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

e
d
trol
work
d trol wo

Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

Copyright © 2004, Texas Instruments Incorporated